

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/585,310	NAKAMURA, MITSUO	
Examiner		Art Unit		Page 1 of 2
SEAN M. MICHALSKI		3724		

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-1,769,546 A	07-1930	RITCHIEY ROSCOE V	198/617
*	B	US-2,932,379 A	04-1960	RIZO RANGABE ALEXANDER	198/617
*	C	US-3,389,662 A	06-1968	JACOBY CHARLES E	104/172.5
*	D	US-3,888,717 A	06-1975	Koyama et al.	156/351
*	E	US-3,921,795 A	11-1975	Vandale et al.	198/382
*	F	US-4,234,371 A	11-1980	Christman, Harold E.	156/96
*	G	US-4,262,794 A	04-1981	Bourgeois, Ronald D.	198/459.8
*	H	US-4,807,525 A	02-1989	de Brock, Raoul	100/153
*	I	US-4,821,869 A	04-1989	Hodlewsky, William G.	198/779
*	J	US-5,846,475 A	12-1998	Yano et al.	264/444
*	K	US-5,853,783 A	12-1998	Rijkaart, Cornelis	426/496
*	L	US-5,901,854 A	05-1999	Ishii, Toru	209/538
*	M	US-6,016,903 A	01-2000	Lochbrunner, Johann	198/370.1

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/585,310	NAKAMURA, MITSUO	
Examiner		Art Unit		Page 2 of 2
SEAN M. MICHALSKI		3724		

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,050,196 A	04-2000	Matsushita et al.	104/172.3
*	B	US-6,109,421 A	08-2000	Ross et al.	198/457.07
*	C	US-6,148,989 A	11-2000	Ecker, Peter M.	198/387
*	D	US-6,152,854 A	11-2000	Carmein, David E. E.	482/4
*	E	US-6,398,015 B1	06-2002	Sedlacek et al.	198/779
*	F	US-7,040,480 B2	05-2006	Sedlacek, Kyle J.	198/457.02
*	G	US-7,357,240 B2	04-2008	Ogimura et al.	198/330
*	H	US-7,426,992 B2	09-2008	Fourney, Matthew L.	198/779
*	I	US-7,506,750 B2	03-2009	Costanzo et al.	198/779
*	J	US-2009/0090599 A1	04-2009	Fourney, Matthew L.	198/345.3
*	K	US-2009/0200139 A1	08-2009	Kissee et al.	198/415
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.